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## FDS6961A

## **Dual N-Channel Logic Level PowerTrench™ MOSFET**

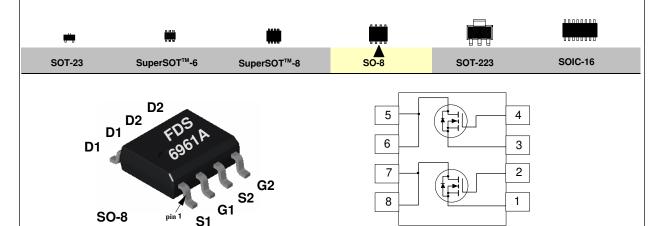
## **General Description**

These N-Channel Logic Level MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

#### **Features**

- Fast switching speed.
- Low gate charge (2.1nC typical).
- High performance trench technology for extremely low R<sub>Devolution</sub>.
- High power and current handling capability.

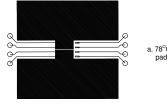


## **Absolute Maximum Ratings** T<sub>A</sub> = 25°C unless other wise noted

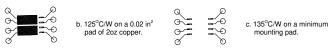
Symbol	Parameter	Ratings	Units
V <sub>DSS</sub>	Drain-Source Voltage	30	V
$V_{GSS}$	Gate-Source Voltage	±20	V
l <sub>D</sub>	Drain Current - Continuous (Note 1a)	3.5	А
	- Pulsed	14	
$P_D$	Power Dissipation for Single Operation (Note 1)	2	W
	Power Dissipation for Single Operation (Note 1a)	1.6	
	(Note 1b)	1	
	(Note 1c)	0.9	
$T_J$ , $T_{STG}$	Operating and Storage Temperature Range	-55 to 150	∞
THERMA	L CHARACTERISTICS		<u>.</u>
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	78	°C/W
R <sub>euc</sub>	Thermal Resistance, Junction-to-Case (Note 1)	40	°C/W

Symbol	Parameter	Conditions	Min	Тур	Max	Units
OFF CHA	RACTERISTICS	•				
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \ I_D = 250 \ \mu\text{A}$	30			V
$\Delta BV_{DSS}/\Delta T$	Breakdown Voltage Temp. Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25 °C		25		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, \ V_{GS} = 0 \text{ V}$			1	μΑ
		T <sub>J</sub> = 55°C			10	μΑ
GSSF	Gate - Body Leakage, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
GSSR	Gate - Body Leakage, Reverse	$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
ON CHAR	ACTERISTICS (Note 2)	<u> </u>	•	•		
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	1	1.8	3	V
$\Delta V_{GS(th)}/\Delta T_{c}$	Gate Threshold Voltage Temp. Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25 °C		-5		mV/°C
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 3.5 \text{ A}$		0.076	0.09	Ω
20(0.1)		T <sub>,1</sub> =125°C		0.11	0.155	
		$V_{GS} = 4.5 \text{ V}, I_D = 2.8 \text{ A}$		0.107	0.14	
I <sub>D(ON)</sub>	On-State Drain Current	$V_{GS} = 10 \text{ V}, \ V_{DS} = 5 \text{ V}$	14			Α
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 15 \text{ V}, I_{D} = 3.5 \text{ A}$		6		S
DYNAMIC	CHARACTERISTICS					•
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 15 \text{ V}, \ V_{GS} = 0 \text{ V}, $ f = 1.0 MHz		220		pF
C <sub>oss</sub>	Output Capacitance	t = 1.0 MHz		50		рF
C <sub>rss</sub>	Reverse Transfer Capacitance			20		pF
SWITCHIN	G CHARACTERISTICS (Note 2)					
t <sub>D(on)</sub>	Turn - On Delay Time	$V_{DS} = 15 \text{ V}, I_{D} = 1 \text{ A}$		3	6	ns
T	Turn - On Rise Time	$V_{GS} = 10 \text{ V}$ , $R_{GEN} = 6 \Omega$		11	22	ns
D(off)	Turn - Off Delay Time			7	14	ns
<u> </u>	Turn - Off Fall Time			3	6	ns
$Q_{g}$	Total Gate Charge	$V_{DS} = 15 \text{ V}, I_{D} = 3.5 \text{ A},$		2.1	4	nC
$Q_{gs}$	Gate-Source Charge	$V_{GS} = 5 \text{ V}$		0.8		nC
$Q_{gd}$	Gate-Drain Charge			0.7		nC
DRAIN-SO	URCE DIODE CHARACTERISTICS AND MAXIM	IUM RATINGS				
l <sub>s</sub>	Maximum Continuous Drain-Source Diode Forward Current				1.3	Α
$V_{SD}$	Drain-Source Diode Forward Voltage $V_{GS} = 0 \text{ V}, I_{S} = 1.3 \text{ A}$ (Note 2)			0.73	1.2	V

<sup>1.</sup>  $R_{\text{BAR}}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\text{BJC}}$  is guaranteed by design while  $R_{\text{BCA}}$  is determined by the user's board design.



a. 78°C/W on a 0.5 in² pad of 2oz copper.





Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width  $\leq 300 \mu s,$  Duty Cycle  $\leq 2.0 \%.$ 

## **Typical Electrical Characteristics**

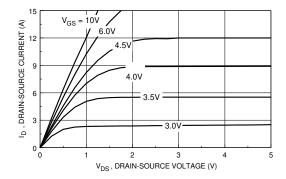


Figure 1. On-Region Characteristics.

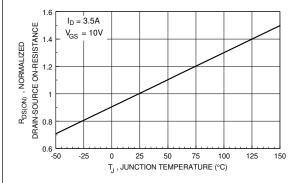


Figure 3. On-Resistance Variation with Temperature.

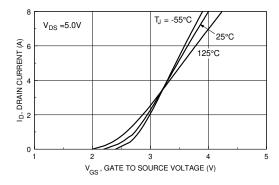


Figure 5. Transfer Characteristics.

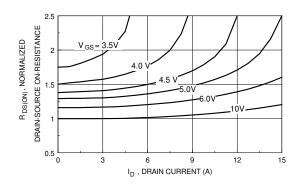


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

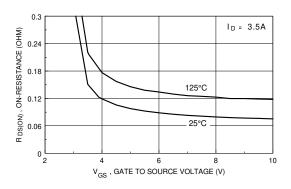


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

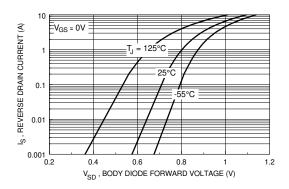
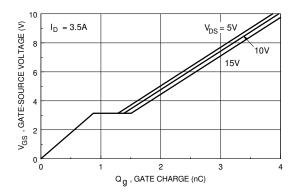


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

## **Typical Electrical Characteristics**



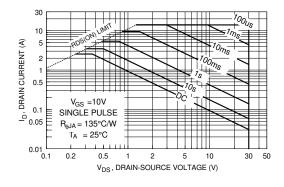
500
200
200
200
200
100
20
4
5 1 MHz
V<sub>GS</sub> = 0 V

10.1 0.2 0.5 1 2 5 10 30

V<sub>DS</sub>, DRAIN TO SOURCE VOLTAGE (V)

Figure 7. Gate Charge Characteristics.





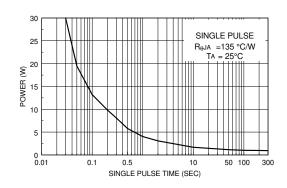


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

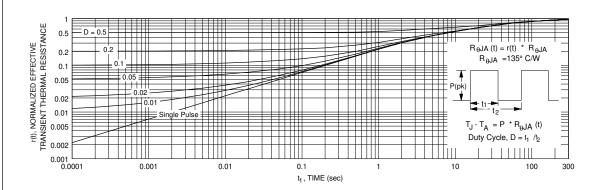


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in note 1c. Transient thermal response will change depending on the circuit board design.

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E<sup>2</sup>CMOS<sup>™</sup> PowerTrench<sup>™</sup>

FACT $^{\text{TM}}$  QFET $^{\text{TM}}$  FACT Quiet Series $^{\text{TM}}$  QS $^{\text{TM}}$ 

 $\begin{array}{lll} \mathsf{FAST}^{\circledast} & \mathsf{Quiet\,Series^{TM}} \\ \mathsf{FASTr^{TM}} & \mathsf{SuperSOT^{TM}\text{-}3} \\ \mathsf{GTO^{TM}} & \mathsf{SuperSOT^{TM}\text{-}6} \\ \mathsf{HiSeC^{TM}} & \mathsf{SuperSOT^{TM}\text{-}8} \end{array}$ 

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